

## ATTY. DOCKET NO.

**SERIAL NO.**

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**APPLICANT**

TANAKA et al

**FILING DATE**

**GROUP**

**March 25, 2005**

2871

## U.S. PATENT DOCUMENTS

11/10/08

## FOREIGN PATENT DOCUMENTS

							TRANSLATION	
DOCUMENT		DATE	COUNTRY	CLASS	SUBCLASS	YES	NO	
JD	3465695 B2	8-2003	JP			partial		
JD	11-95167 A	4-1999	JP			partial		
JD	2002-107750 A	4-2002	JP			partial		
JD	2001-154181 A	6-2001	JP			partial		
JD	1 109 053 A2	6-2001	EP					
JD	8-101367 A	4-1986	JP			partial		
JD	2003-172941 A	6-2003	JP			partial		

**OTHER DOCUMENTS** (including Author, Title, Date, Pertinent pages, etc.)

Examiner	/James Dudek/	Date Considered	10/25/2006
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Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.

**Form PTO-FB-A820 (Also PTO-1449)**